

PERIPHERAL EQUIPMENT DIVISION

8/15/76 Rev. B

TITLE TEMPERATURE COM	рів no. DK3050 В			
PRODUCT TAPE [] DISK PA LINE: FORMATTER []	EQUIPMEN PCBA 1	T CHANGED	MODEL SERIES AFFECTED D3000	EFFECTIVE DATE April 5, 1976
CLASS OF BULLETIN: IMPROVEMENT RETROFIT ON FAILURE RETROFIT RECOMMENDED SERVICE INFORMATION ONLY			All 200 tpi Di fitted with Te Write Compens	

PURPOSE:

To provide the necessary data in the form of test configurations, test procedures and adjustment procedures for the temperature compensation portion of the Temperature and Write Compensation PCBA. This information is not at present included in the current D3000 manual, and will appear in the revised edition, which will be available in April 1976. This portion of the PCBA operates, in conjunction with a thermistor mounted adjacent to the positioner, to provide a signal, which is proportional to temperature and offsets the heads accordingly. Adjustment will be required if the Temperature and Write Compensation PCBA is replaced or if any component in the temperature compensation circuit is changed.

NOTE

All references to test points are on the Temperature-And-Write Compensation PCBA as shown in Figure 1 on Page 7

TEST_CONFIGURATION:

- (1) The test disk cartridge must be stored for a minimum of 90 minutes at the same ambient temperature as the disk drive prior to insertion in the disk drive.
- (2) Insert the test disk cartridge.
- (3) Run the disk drive in the READY mode for a minimum of 5 minutes.
- (4) Connect a disk exerciser capable of selecting the upper and lower platters and also capable of positioning the heads to any desired cylinder address.
- (5) Place a temperature probe adjacent to the thermistor.

Should Additional Information Be Required — Contact

PERTEC

Distribution Code 6318

PERIPHERAL EQUIPMENT DIVISION 9600 Irondale Avenue, Chatsworth, California 91311 Phone (213) 882-0030 / TWX (910) 494-2093 ATTENTION: PRODUCT SUPPORT MANAGER PERIEC 20-K012C(1)



PERIPHERAL EQUIPMENT DIVISION

TITLE TE

TEMPERATURE COMPENSATION ADJUSTMENT PROCEDURE

PIB NO. DK3050B

NOTE

Temperature measuring equipment should have a range from 68° F to 87.8° F (20° C to 31° C) with an error limit not greater than $\pm 1^{\circ}$ F ($\pm 0.5^{\circ}$ C).

(6) Using a Digital Voltmeter, connect the positive test lead to TP4 on the Temperature-And-Write Compensation PCBA, and the common test lead to TP5 (ground, on the same PCBA).

TEST PROCEDURE:

- (1) Establish the test configuration described in previous paragraph.
- (2) Observe the temperature probe reading.
- (3) Position the heads to cylinder addresses (in Table 1) that are within the Temperature range indicated by the observed temperature probe reading.
- (4) Observe the voltage readings at TP4 for each cylinder address in Step (3).

NOTE

If any of the voltages in Step (4) are out of tolerance (see Table 1), perform the adjustment procedure in next paragraph.

(5) Proceed with the scaling resistor verification on Page 4.

ADJUSTMENT PROCEDURE:

- (1) Note the temperature adjacent to the thermistor.
- (2) Move the DVM Positive probe to TP3 on the Temperature-And-Write Compensation PCBA. Maintain the DVM ground lead on TP5.
- (3) Adjust R15 on the PCBA to attain a voltage that corresponds to the temperature to the temperature noted in Step (1). See Table 2.

PERTEC PRODUCT IMPROVEMENT BULLETIN

PERIPHERAL EQUIPMENT DIVISION							
TITLE	TEMPER	ATURE COME	ENSATIO	N AD	JUSTMENT PROCE	DURE	PIB NO. DK3050 B
			T .	ABLE	1,	,	
	шьмор	ក្នុយដេចជ			ADDRESS	TCTP4 VO	፣ መልረፑ
	TEMPE)	RATURE O _F	<u>C11111</u>	NDC IV	ADDRESS	10117	LIAGE
	20	68	64	(100	octal)	+0.432 ±	· ·
	20	68		•	octal)	+0.217	II
	20	68	256	(400	octal)	-0.204	11
	21	69.8		•	octal)	+0.346	
	21	69.8			octal)+0.174	_	H H
	21	69.8	256	(400	octal)	-0.163	
	22	71.6		•	octal)	+0.260	H
	22	71.6		•	octal)	+0.131	"
	22	71.6	256	(400	octal)	-0.122	u
	23	73.4		•	octal)	+0.174	н
	23	73.4		-	octal)	+0.088	"
	23	73.4	256	(400	octal)	-0.081	· · · · · · · · · · · · · · · · · · ·
	24	75.2		-	octal)	40.880	"+0.088
	24	75.2		•	octal)	+0.045	"
ı	24	75.2		-	octal)	040	11
ı	25	77.0		-	octal)	.000	11
	25 25	77.0		•	octal)	.000	II It
	25	77.0		•	octal)	.000	
1	26	78.8		-	octal)		0.088
	26	78.8		•	octal)	045	11
1	26	78.8	256	(400	octal)	+ .040	
İ	27	80.6			octal)	-0.174	
į	27	80.6		•	octal)	-0.088	H .
	27	80.6			octal)	+0.081	"
	28	82.4		•	octal)	-0.260	11
	28	82.4		•	octal)	-0.131	"
	28	82.4			octal)	+0.122	
İ	29	84.2		•	octal)	-0.346	
İ	29 29	84.2			octal) - 0.174	±0.163	
l	29	84.2		•	octal)	+0.163	
	30	86.0		•	octal)	-0.432 -0.217	11
	30 30	86.0 86.0		•	octal) octal)	-0.217 +0.204	"
i	31 31	87.8 87.8			octal) -0.260	-0.518	11
	31	87.8 87.8			octal) + 0.245		U
	-	0,.0		(000002/ (0.0010		
i					•		

PERTEC

PRODUCT IMPROVEMENT BULLETIN

PERIPHERAL EQUIPMENT DIVISION

TITLE TEMPERATURE COMPENSATION ADJUSTMENT PROCEDURE

PIB NO. DK3050B

TABLE 1 (continued)

TEMP	ERATURE	CYL	NDER	ADDRESS	TCTP4	VOLTAGE
o _C	\circ_{F}					
32	89.6	64	(100	octal)	-0.604	± 0.100v
32	89.6	128	(200	octal)	-0.305	п
32	89.6	256	(400	octal)	+0.28 6	**
33	91.4	64	(100	octal)	-0.690	11
33	91.4	128	(200	octal)	-0.348	11
33	91.4	256	(400	octal)	+0.327	11
34	93.2	64	(100	octal)	-0.778	n
34	93.2	128	(200	octal)	-0.391	н
34	93.2	256	(400	octal)	+0.368	**
35	95.0	64	(100	octal)	-0.864	· u
35	95.0	128	(200	octal)	-0.434	ti
35	95.0	256	(400	octal)	+0.409	11

TABLE 2

°c	$\circ_{ m F}$	TCTP3 VOLTAGE
22.0	71.6	+2.898 to +2.954V
23.0	73.4	+2.970 to +3.030V
24.0	75.2	+3.044 to +3.106V
25.0	77.0	+3.118 to +3.182V
26.0	78.8	+3.198 to +3.262V
27.0	80.6	+3.277 to +3.343V
28.0	82.4	+3.361 to +3.429V
29.0	84.2	+3.440 to +3.510V
30.0	86.0	+3.514 to +3.586V
31.0	87.8	+3.604 to +3.676V

SCALING RESISTOR VERIFICATION:

- (1) Move the DVM positive probe to TP2 on the Temperature-And-Write Compensation PCBA.
- (2) Adjust R16 on the Temperature-And-Write Compensation PCBA to +1.0V.
- (3) Move the DVM positive probe to TP4 on the Temperature-And-Write Compensation PCBA.

PERTEC

PRODUCT IMPROVEMENT BULLETIN

PERIPHERAL EQUIPMENT DIVISION

TITLE TEMPERATURE COMPENSATION ADJUSTMENT PROCEDURE

PIB NO. DK3050B

SCALING RESISTOR VERIFICATION: (continued)

(4) Using the disk exerciser, refer to Table 3 and check that the voltage at TP4 is within the range specified for each of the cylinder addresses listed.

NOTE

If the voltages on TP4 are not within limits for each cylinder address in Step (4), there may be a component failure in the scaling resistor and/or the cylinder address circuitry.

(5) Proceed with the environment temperature adjustment.

TABLE 3

CYLINDER	ADDRESS	TCTP4	VOLTAGE
32 (40	octal)	+1.49	to +1.82V
96 (140	octal)	+0.98	to +1.20V
160 (240	octal)	+0.50	to +0.61V
224 (340	octal)	-0.07	to +0.05V
288 (440	octal)	-0.51	to -0.41V
352 (540	octal)	-1.12	to -0.92V
400 (620	octal)	-1.72	to -1.40V

ENVIRONMENT TEMPERATURE ADJUSTMENT:

NOTE

Location of the heads is not relevant to this adjustment.

- (1) Note the temperature reading on the probe adjacent to the thermistor.
- (2) Move the DVM positive probe to TP2 on the Temperature-And-Write Compensation PCBA.
- (3) Adjust R16 to the voltage (Table 4) corresponding to the temperature reading observed in Step (1).
- (4) Remove DVM positive probe from TP2.
- (5) Remove DVM negative probe from TP5.
- (6) Remove Disk exerciser.
- (7) Deenergize disk drive.



PERIPHERAL EQUIPMENT DIVISION

TITLE	PIB NO.
TITLE TEMPERATURE COMPENSATION ADJUSTMENT PROCEDURE	DK3050 B

TABLE 4

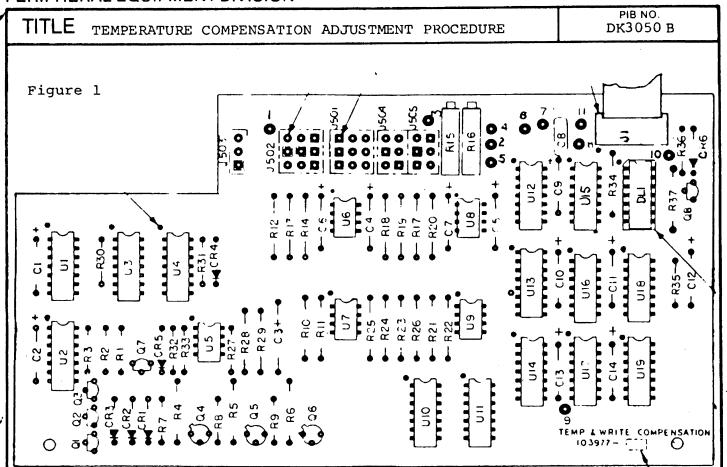
	MPERATURE	TCTP2 VOLTAGE
°C	$^{\circ}_{\mathrm{F}}$	
20	68.0	+0.40V
21	69.8	+0.32V
22	71.6	+0.24V
23	73.4	+0.16V
24	75.2	+0.08V
25	77.0	+0.00V
26	78.8	-0.08V
27	80.6	-0.16V
28	82.4	-0.24V
29	84.2	-0.32V
30	86.0	-0.40V
31	87.8	-0.48V
32	89.6	-0.56V
33	91.4	-0.64V
34	93.2	-0.72V
35	95.0	-0.80V

NOTE

Mechanical CE Alignment (Paragraph 6.13, D3000 manual) must be performed if any temperature compensation adjustments are made.



PERIPHERAL EQUIPMENT DIVISION



REFERENCE DRAWINGS:

Schematic number 103976 (sheet 1)

Assembly number 103977